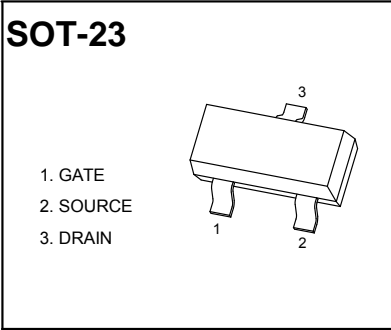


SOT-23 Plastic-Encapsulate MOSFETS

30V N-Channel MOSFET

<b>V<sub>(BR)DSS</sub></b>	<b>R<sub>DS(on)Typ</sub></b>	<b>I<sub>D Max</sub></b>
60V	105mΩ@10V	3A
	125mΩ@4.5V	



DESCRIPTION

The SI2310 uses advanced trench technology to provide excellent R<sub>DS(ON)</sub>, low gate charge and operation with gate voltage as low as 2.5V. This device is suitable for use as a battery protection or in other switching application.

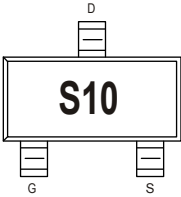
FEATURE

- High power and current handing capability
- Lead free product is acquired
- Surface mount package

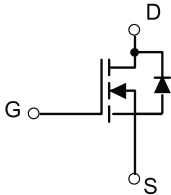
APPLICATION

- Battery Switch
- DC/DC Converter

MARKING



Equivalent circuit



PACKAGE SPECIFICATIONS

Package	Reel Size	Reel DIA. (mm)	Q'TY/Reel (pcs)	Box Size (mm)	QTY/Box (pcs)	Carton Size (mm)	Q'TY/Carton (pcs)
SOT-23	7'	178	3000	203×203×195	45000	438×438×220	180000

Maximum Ratings and Thermal Characteristics (TA = 25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V <sub>DS</sub>	60	V
Gate-Source Voltage	V <sub>GS</sub>	±20	
Continuous Drain Current	I <sub>D</sub>	3	A
Pulsed Drain Current <sup>1)</sup>	I <sub>DM</sub>	10	A
Maximum Power Dissipation <sup>1),2)</sup>	P <sub>D</sub>	0.35	W
Junction Temperature	T <sub>J</sub>	150	°C
Storage Temperature	T <sub>stg</sub>	-55 to 150	°C
Thermal Resistance from Junction-to-Ambient (t≤5s)	R <sub>θJA</sub>	357	°C/W

Notes  
 1) Pulse width limited by maximum junction temperature.  
 2) Surface Mounted on FR4 Board, t ≤ 5 sec.

The above data are for reference only.

## MOSFET ELECTRICAL CHARACTERISTICS

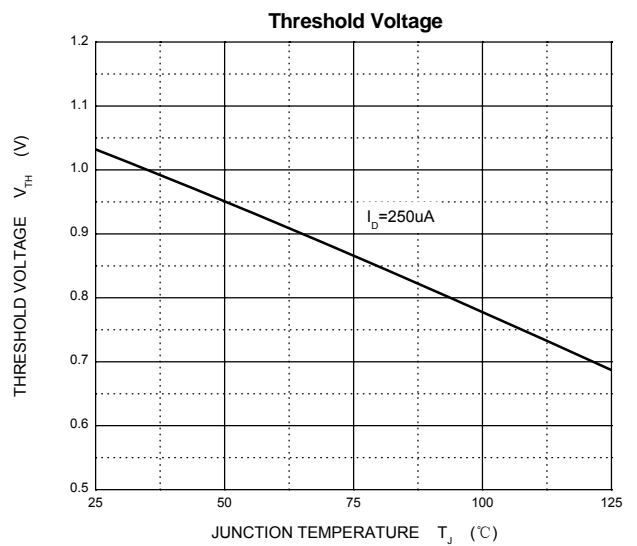
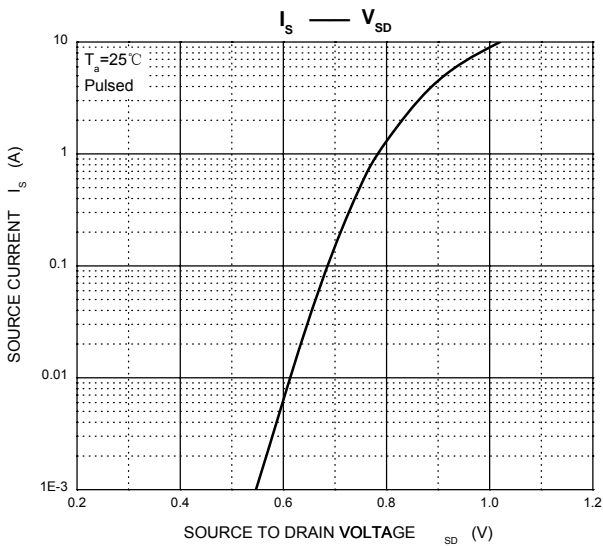
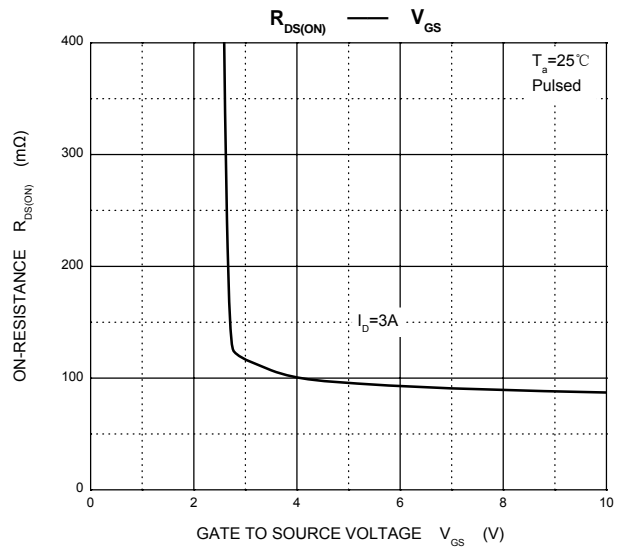
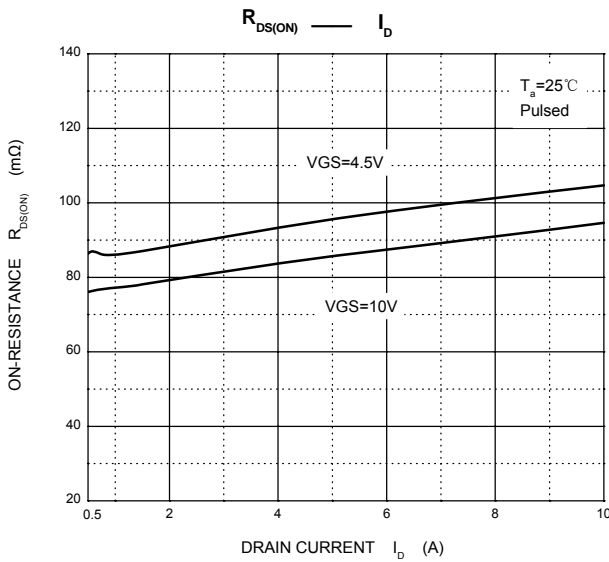
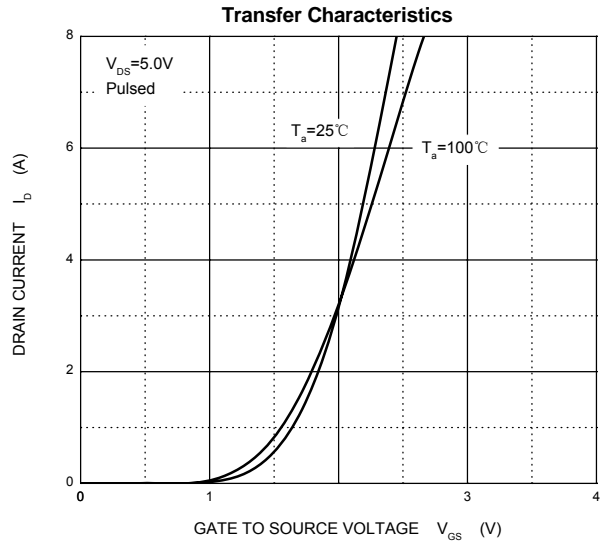
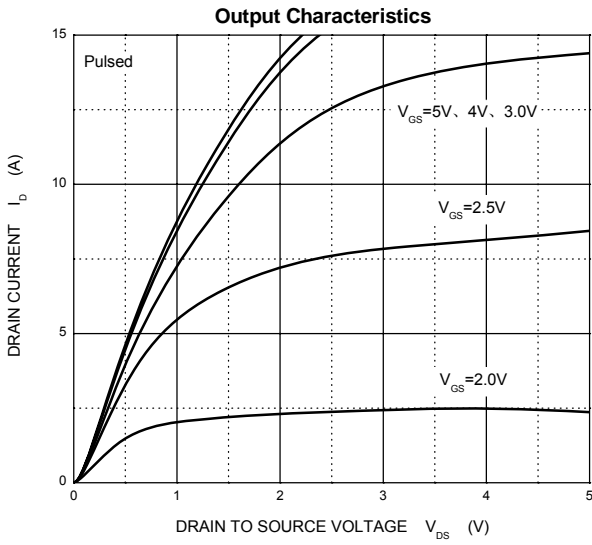
 $T_a=25\text{ }^\circ\text{C}$  unless otherwise specified

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
<b>STATIC CHARACTERISTICS</b>						
Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	60			V
Zero gate voltage drain current	$I_{DSS}$	$V_{DS} = 60V, V_{GS} = 0V$			1	$\mu A$
Gate-body leakage current	$I_{GSS}$	$V_{GS} = \pm 20V, V_{DS} = 0V$			$\pm 100$	nA
Gate threshold voltage (note 3)	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	0.5		2	V
Drain-source on-resistance (note 3)	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 3A$			105	$\Omega$
		$V_{GS} = 4.5V, I_D = 3A$			125	$\Omega$
Forward transconductance (note 3)	$g_{FS}$	$V_{DS} = 15V, I_D = 2A$	1.4			S
Diode forward voltage (note 3)	$V_{SD}$	$I_S = 3A, V_{GS} = 0V$			1.2	V
<b>DYNAMIC CHARACTERISTICS (note 4)</b>						
Input Capacitance	$C_{iss}$	$V_{DS} = 30V, V_{GS} = 0V, f = 1MHz$		247		pF
Output Capacitance	$C_{oss}$			34		pF
Reverse Transfer Capacitance	$C_{rss}$			19.5		pF
<b>SWITCHING CHARACTERISTICS (note 4)</b>						
Turn-on delay time	$t_{d(on)}$	$V_{GS} = 10V, V_{DD} = 30V,$ $I_D = 1.5A, R_{GEN} = 1\Omega$		6		ns
Turn-on rise time	$t_r$			15		ns
Turn-off delay time	$t_{d(off)}$			15		ns
Turn-off fall time	$t_f$			10		ns
Total Gate Charge	$Q_g$	$V_{DS} = 30V, V_{GS} = 4.5V, I_D = 3A$		6		nC
Gate-Source Charge	$Q_{gs}$			1		nC
Gate-Drain Charge	$Q_{gd}$			1.3		nC

**Notes :**

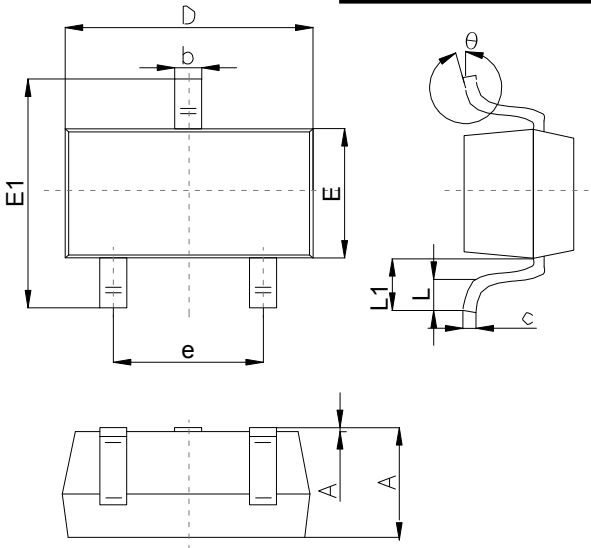
1. Repetitive rating : Pulse width limited by junction temperature.
2. Surface mounted on FR4 board ,  $t_s \leq 10s$ .
3. Pulse Test : Pulse Width  $\leq 300\mu s$ , Duty Cycle  $\leq 0.5\%$ .
4. Guaranteed by design, not subject to producing.

## Typical Characteristics



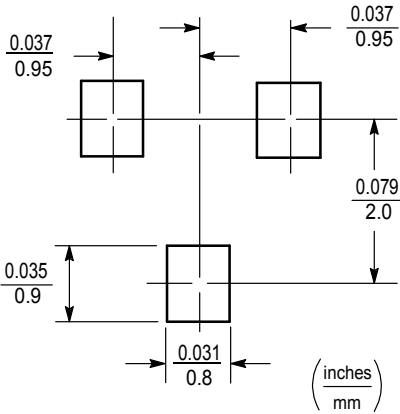
**Outlitne Drawing**

**SOT-23 Package Outline Dimensions**



Symbol	Dimensions In Millimeters		
	Min	Typ	Max
A	1.00		1.40
A1			0.10
b	0.35		0.50
c	0.10		0.20
D	2.70	2.90	3.10
E	1.40		1.60
E1	2.4		2.80
e		1.90	
L	0.10		0.30
L1	0.4		
theta	0°		10°

**Suggested Pad Layout**



Note:  
 1. Controlling dimension:in/millimeters. 2.General tolerance: ±0.05mm.  
 3.The pad layout is for reference purposes only.